

Notice of References Cited	Application/Control No. 10/697,181	Applicant(s)/Patent Under Reexamination KULKARNI ET AL.	
	Examiner Michael Bernshteyn	Art Unit 1713	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,660,484	12-2003	Charych et al.	435/7.1
*	C	US-6,630,154	10-2003	Fraker et al.	424/423
*	D	US-6,538,072	03-2003	Kiessling et al.	525/326.1
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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